

AONS68520

150V N-Channel AlphaSGT™

General Description

- Trench Power MOSFET technology
- \bullet Low $R_{\text{DS(ON)}}$ and optimized swiching performance
- High Current Capability
- RoHS 2.0 and Halogen-Free Compliant

Product Summary

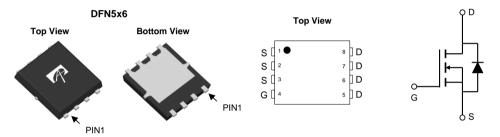
 $\begin{array}{lll} V_{DS} & 150V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 102A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 9.6 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 8V) & < 11 m\Omega \end{array}$

Applications

- Server and Telecom
- Industrial

100% UIS Tested 100% Rg Tested





Orderable Part Number	Package Type	Form	Minimum Order Quantity		
AONS68520	DFN 5x6	Tape & Reel	3000		

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage	е	V_{DS}	150	V	
Gate-Source Voltage	ate-Source Voltage		±20	V	
Continuous Drain	T _C =25°C	I-	102		
Current	T _C =100°C	ID .	64	A	
Pulsed Drain Current ^C		I _{DM}	176		
Continuous Drain	T _A =25°C	1	19	^	
Current	T _A =70°C	IDSM	15	— A	
Avalanche Current ^C		I _{AS}	54	А	
Avalanche energy	L=0.1mH	E _{AS}	146	mJ	
	T _C =25°C	P _D	208	W	
Power Dissipation ^B	T _C =100°C	r _D	83	VV	
	T _A =25°C	D	7.3	W	
Power Dissipation ^A	T _A =70°C	P _{DSM}	4.7		
Junction and Storage	e Temperature Range	T _J , T _{STG}	-55 to 150	°C	

Thermal Characteristics						
Parameter		Symbol	Symbol Typ Max		Units	
Maximum Junction-to-Ambient A	t ≤ 10s	Б	14	17	°C/W	
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	40	55	°C/W	
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	0.45	0.6	°C/W	



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units	
STATIC F	STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	150			V	
		V _{DS} =150V, V _{GS} =0V			1	μA	
I _{DSS}	Zero Gate Voltage Drain Gurrent	T _J =55°	Č		5	μΑ	
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V			±100	nA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2.6	3.25	3.9	V	
		V _{GS} =10V, I _D =20A		8	9.6	mΩ	
R _{DS(ON)}	R _{DS(ON)} Static Drain-Source On-Resistance	T _J =125°	,C	14.5	18	11122	
		V_{GS} =8 V , I_D =20 A		8.6	11	mΩ	
g _{FS}	Forward Transconductance	V_{DS} =5V, I_D =20A		55		S	
V_{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V		0.7	1	V	
I _S	Maximum Body-Diode Continuous Current				102	Α	
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance			3440		pF	
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =75V, f=1MHz		490		pF	
C _{rss}	Reverse Transfer Capacitance	1		10		pF	
R_g	Gate resistance	f=1MHz	0.5	1	1.5	Ω	
SWITCHI	NG PARAMETERS						
Q _g (10V)	Total Gate Charge			48	58	nC	
Q_{gs}	Gate Source Charge	$V_{GS} = 10V, V_{DS} = 75V, I_{D} = 20A$		15		nC	
Q_{gd}	Gate Drain Charge			9.5		nC	
Q _{oss}	Output Charge	V_{GS} =0V, V_{DS} =75V		72		nC	
t _{D(on)}	Turn-On DelayTime			15		ns	
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =75V, R_L =3.75 Ω	٠,	6.8		ns	
$t_{D(off)}$	Turn-Off DelayTime	R_{GEN} =3 Ω		30		ns	
t _f	Turn-Off Fall Time			7.4		ns	
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, di/dt=100A/μs		68		ns	
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =20A, di/dt=100A/μs		82		nC	

A. The value of R_{9JA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R ala t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(MAX)}$ =150° C.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

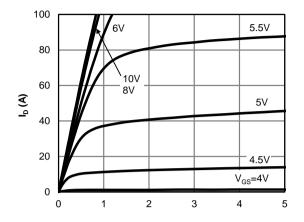
E. The static characteristics in Figures 1 to 6 are obtained using <300 µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsin k, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.

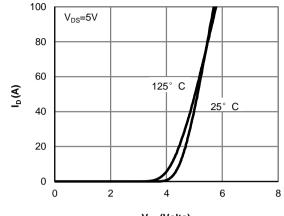
G. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ$ C.



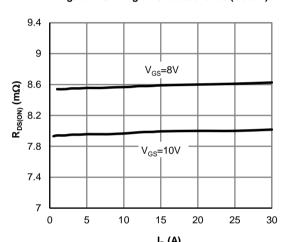
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



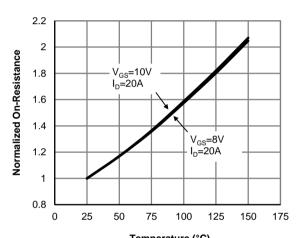
V_{DS} (Volts) Figure 1: On-Region Characteristics (Note E)



V_{GS} (Volts)
Figure 2: Transfer Characteristics (Note E)



 ${
m I_D}$ (A) Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction
Temperature (Note E)

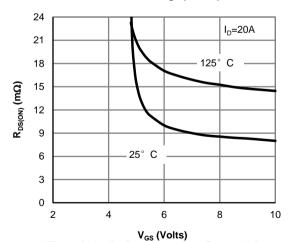
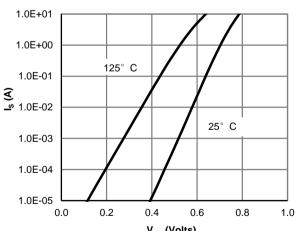


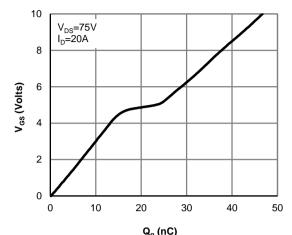
Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



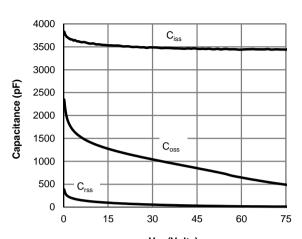
V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



 ${\bf Q_g}$ (nC) Figure 7: Gate-Charge Characteristics



V_{DS} (Volts)
Figure 8: Capacitance Characteristics

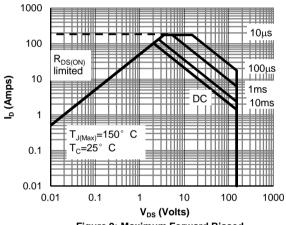
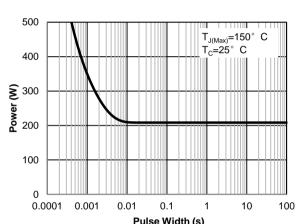


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)



Pulse Width (s)
Figure 10: Single Pulse Power Rating Junction-toCase (Note F)

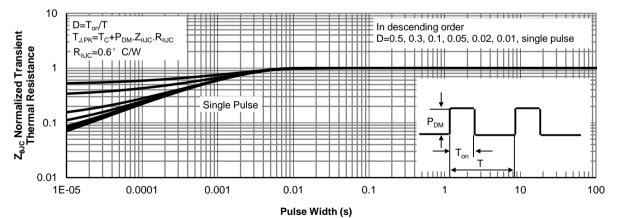
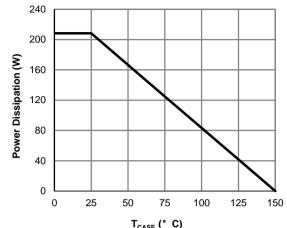


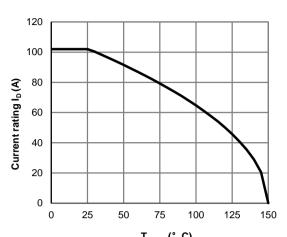
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



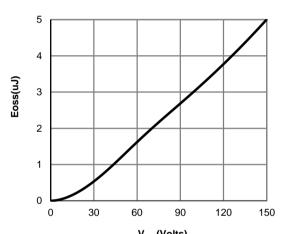
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



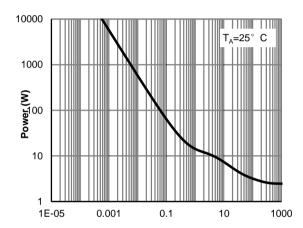
T_{CASE} (° C)
Figure 12: Power De-rating (Note F)



T_{CASE} (° C)
Figure 13: Current De-rating (Note F)



V_{DS} (Volts) Figure 14: Coss stored Energy



Pulse Width (s) Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note G)

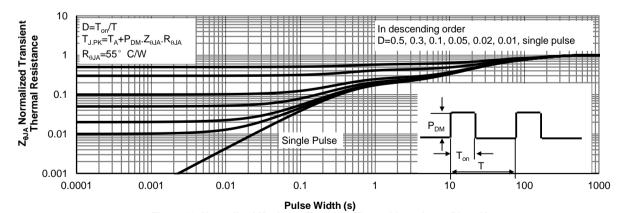


Figure 16: Normalized Maximum Transient Thermal Impedance (Note G)

Figure A: Gate Charge Test Circuit & Waveforms

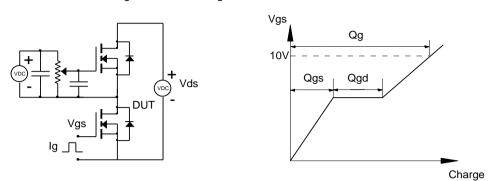


Figure B: Resistive Switching Test Circuit & Waveforms

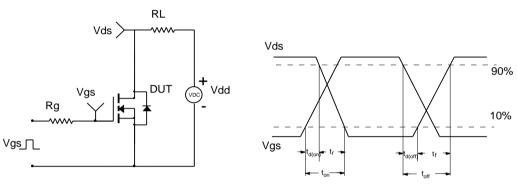


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

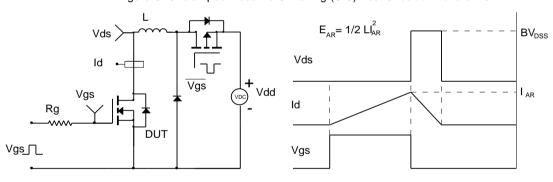
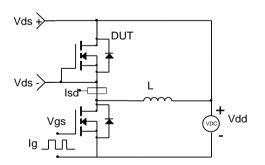
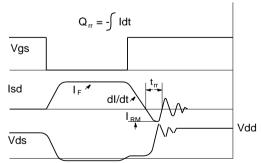


Figure D: Diode Recovery Test Circuit & Waveforms





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